

# Development of an enhanced lateral drift sensor

Breaking the small-pitch paradigm

Hendrik Jansen, Anastasiia Velyka  
Geneva, 24.1.2018

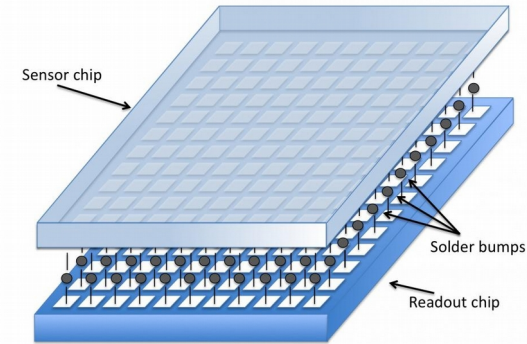
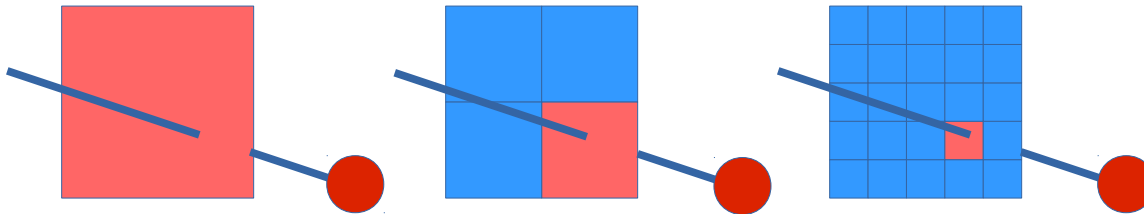


# Breaking the small-pitch paradigm

Buried implants for local manipulation of the electric field in planar particle sensors

**Achieve improved position resolution of charged particle sensors**

- This is usually done by down-sizing the pitch

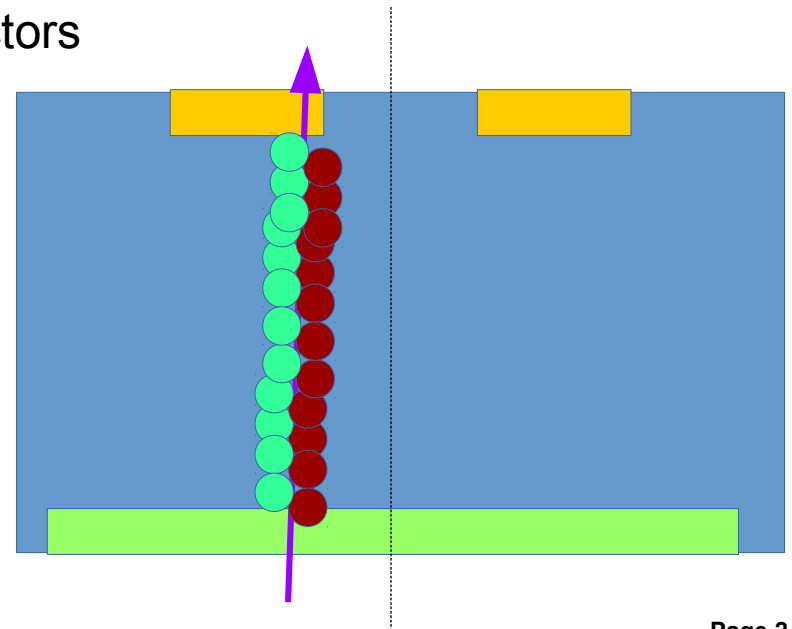


- Increases number of readout channels
- Potentially higher band width from detectors
- Less area on-chip per channel
- Higher power dissipation

- **Miniturisation has limits**

- Size of bump bonds, wire bond pads, cross talk, ...
- Minimum of logic/processing on-chip

→ Is there another solution?

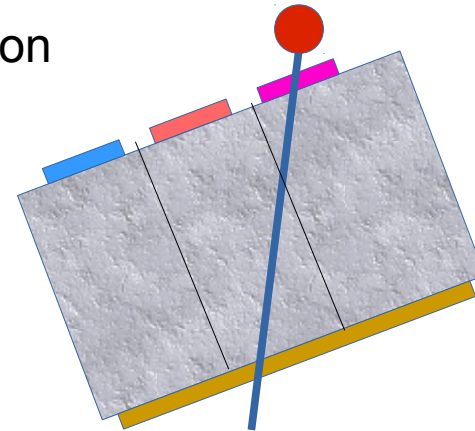
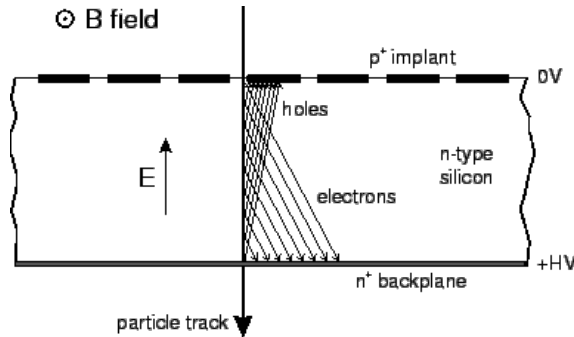


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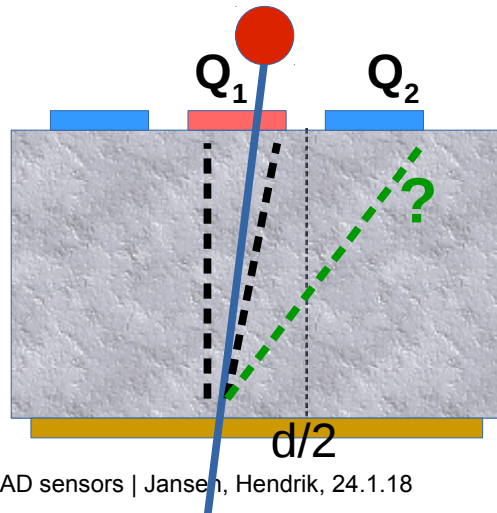
Buried implants for local manipulation of the electric field in planar particle sensors

Achieve improved position resolution of charged particle sensors

- For CLIC/ILC (50  $\mu\text{m}$  thin sensors),  
Lorentz drift, diffusion and tilting is no solution



→ What else can be done?

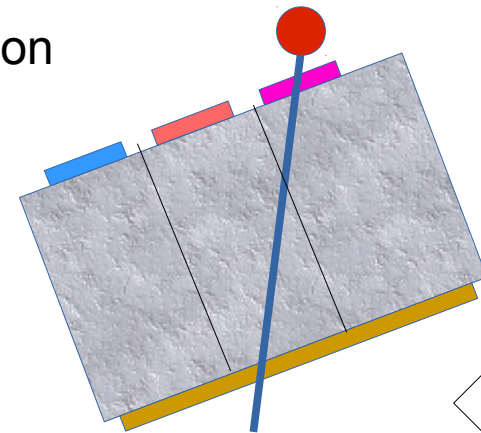
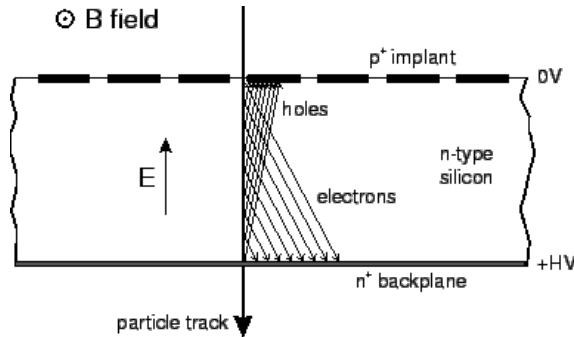


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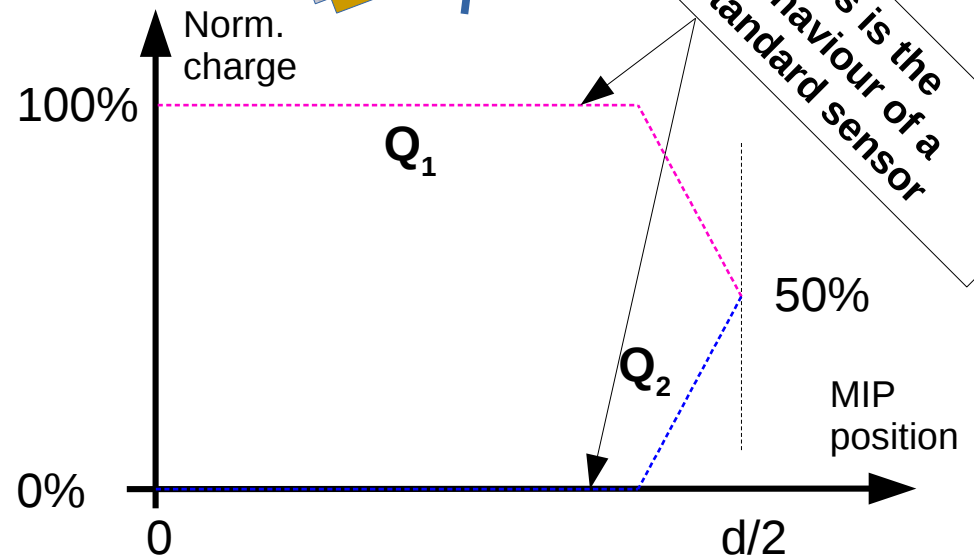
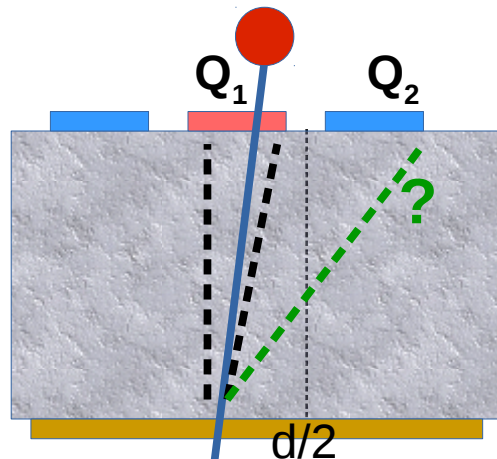
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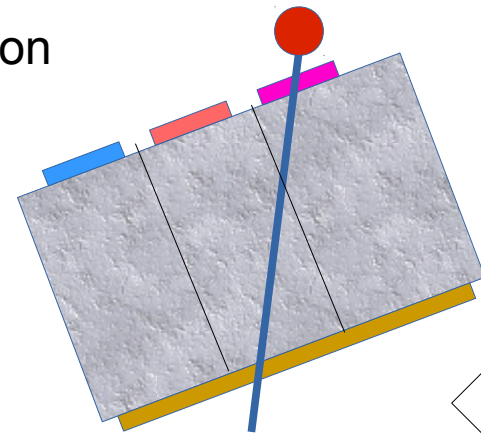
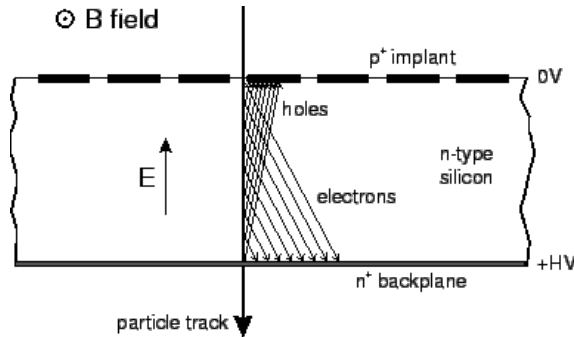


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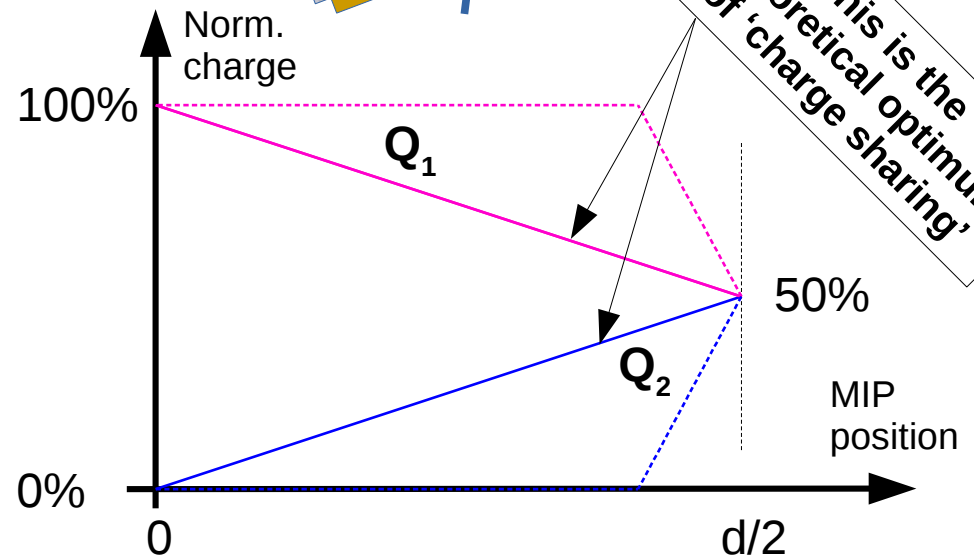
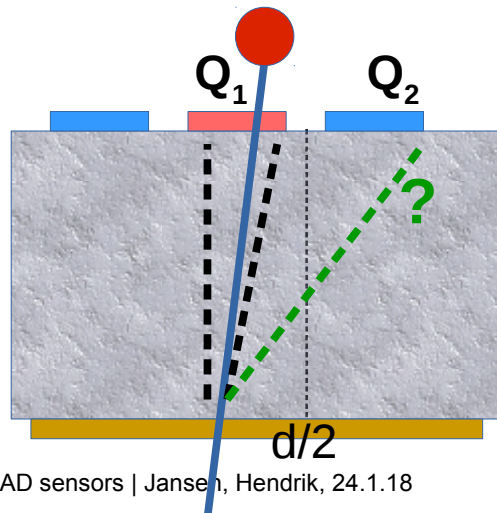
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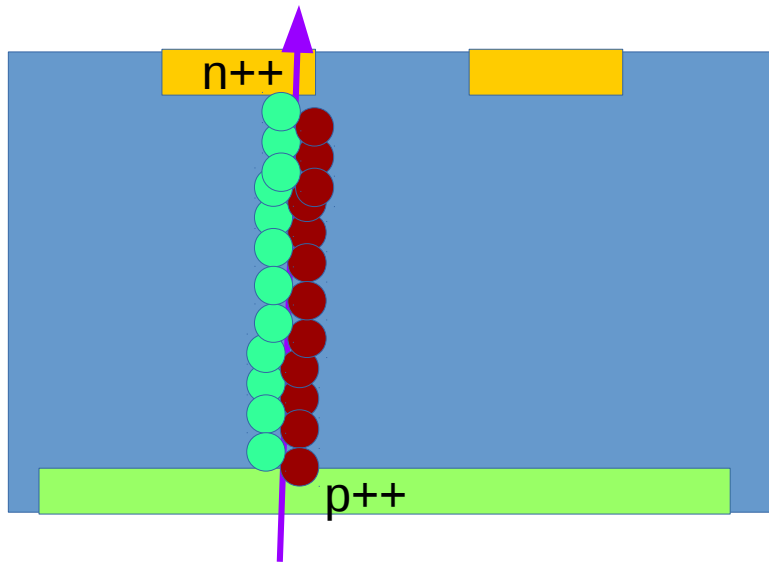
This is the theoretical optimum of 'charge sharing'

# Enhanced lateral drift sensors

Towards the theoretical optimum of position resolution

**Achieve improved position resolution of charged particle sensors**

- Induce lateral drift by locally engineering the electric field

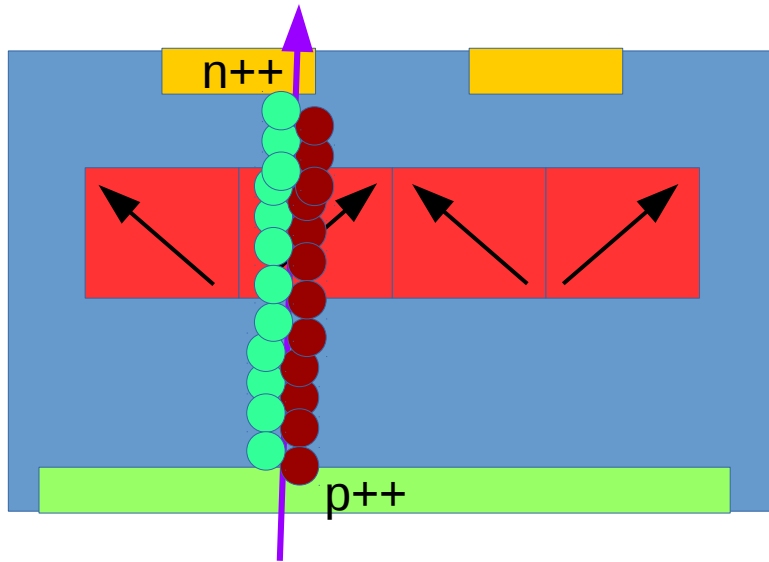


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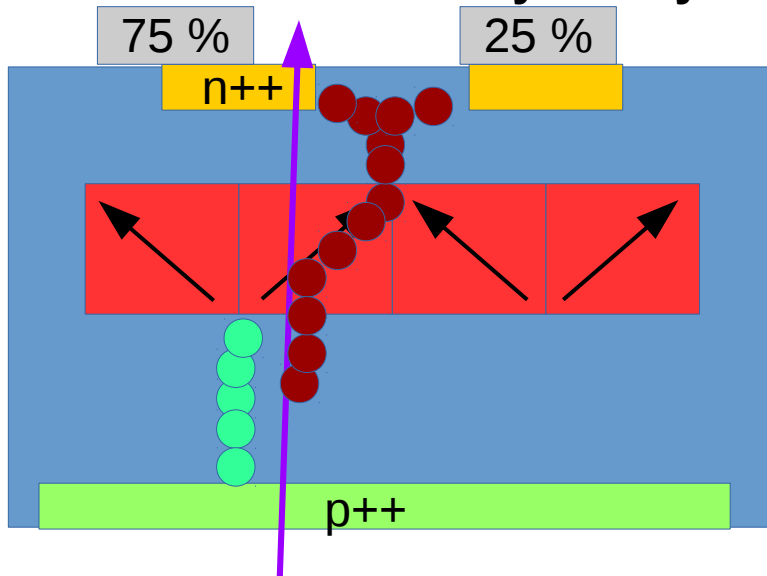


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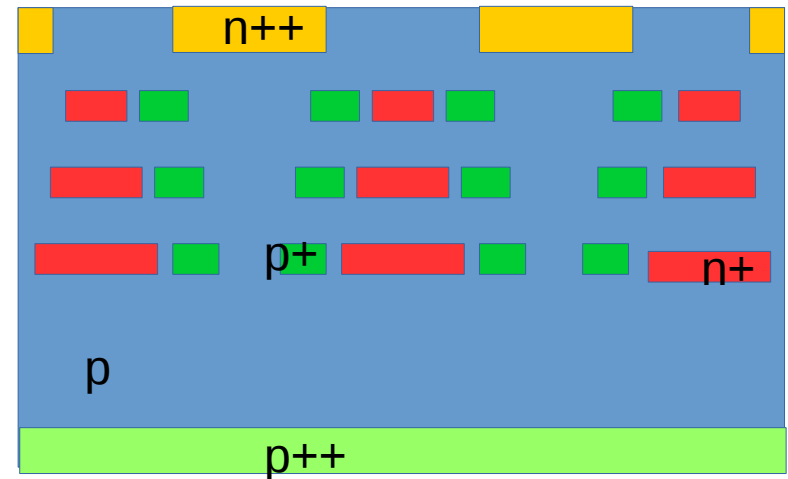
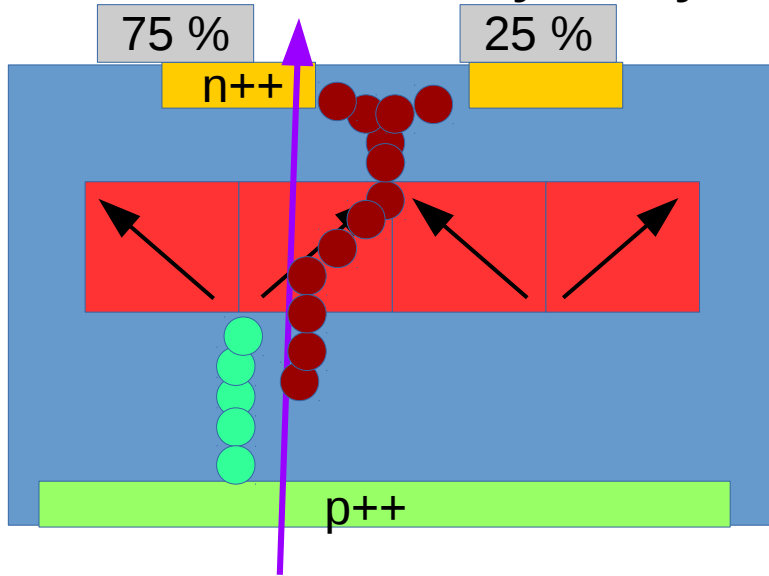


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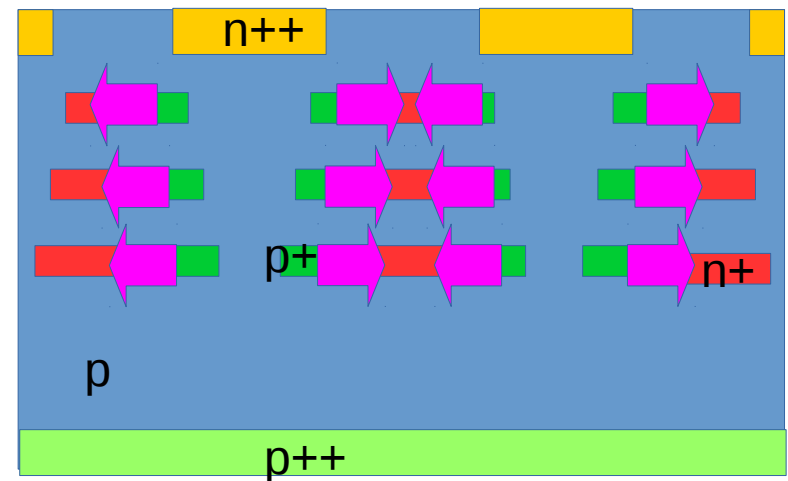
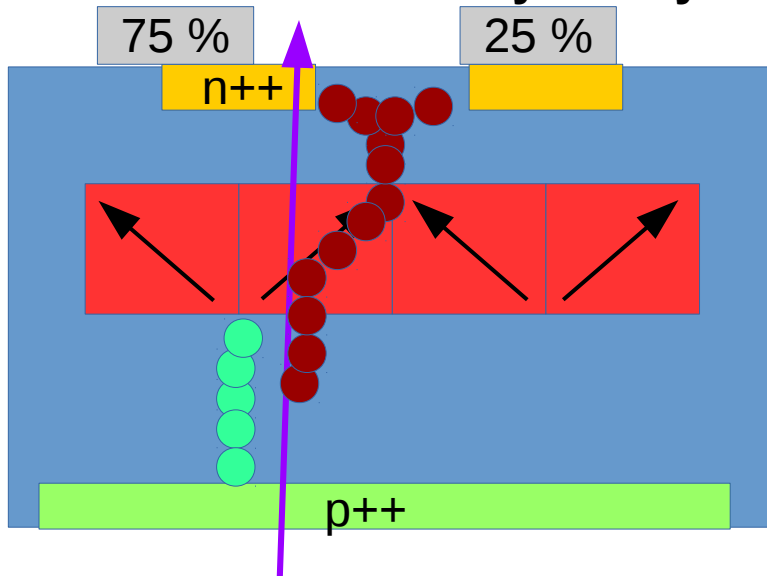


# Enhanced lateral drift sensors

Towards the theoretical optimum of position resolution

Achieve improved position resolution of charged particle sensors

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- LATERAL electric field
- Position-dependent charge sharing (collection at >1 electrode)
- Awareness of hemisphere (left/right of implant)

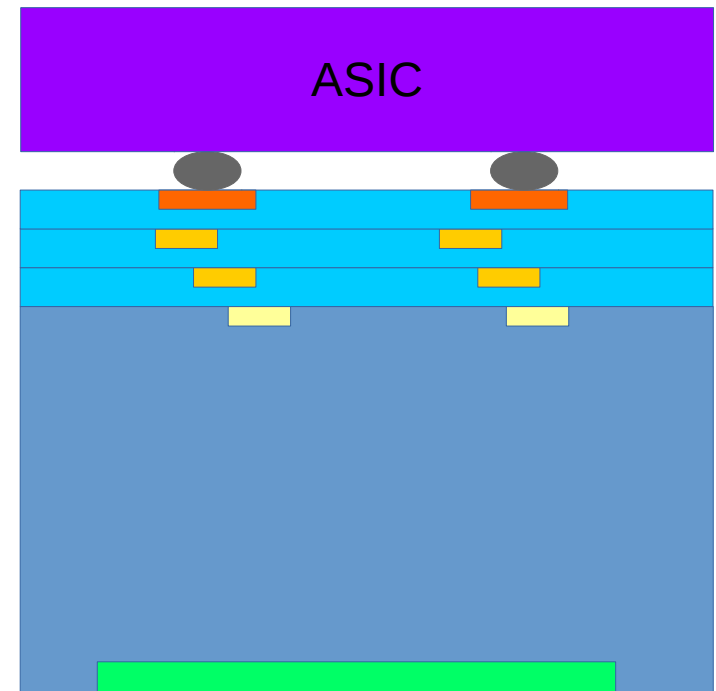
→ **ENHANCED LATER DRIFT (ELAD)**

# No one has done this before

... can we do it?

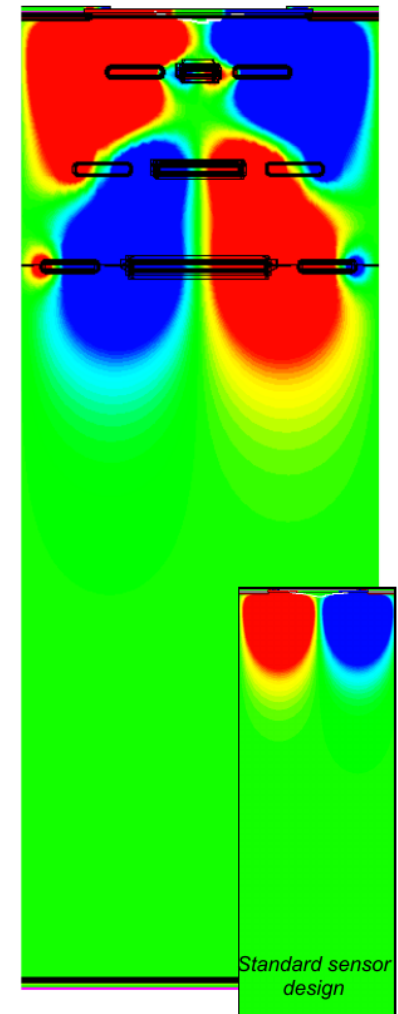
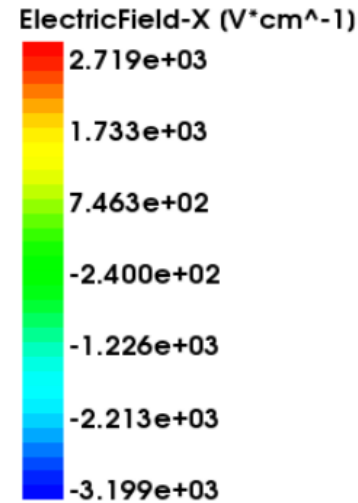
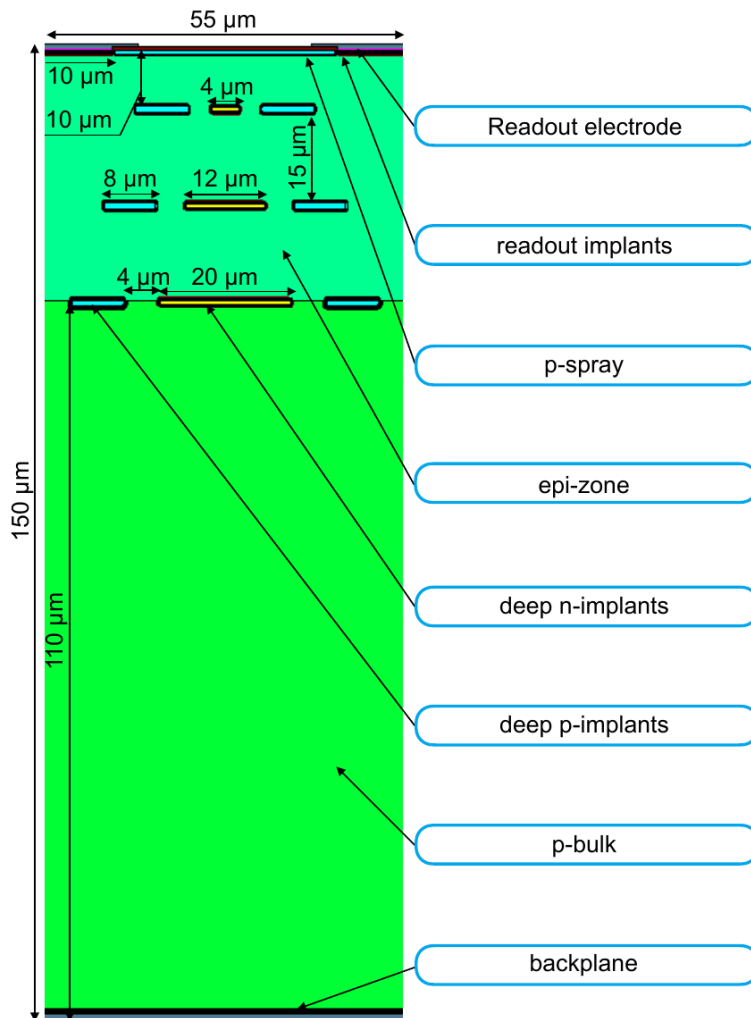
**Produce a *functional prototype* by the end of the funding period**

- Extensive **device simulation** studies by Anastasiia Velyka
  - Find optimal parameters for an ELAD sensor
- **Process simulations** to find process for manufacture
  - alternate implantation and epitaxial growth
- **Define structures and parameters** for production
  - Feed-back to SDE structures
- **Develop process** with partners (ISE, CiS)
  - Test structures
  - Full wafers
- **Flip chipping** with TimePix3 sensor
- **Tests at DESY/CERN**
  - Lab: IV, CV
  - Test beam



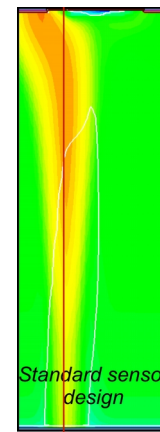
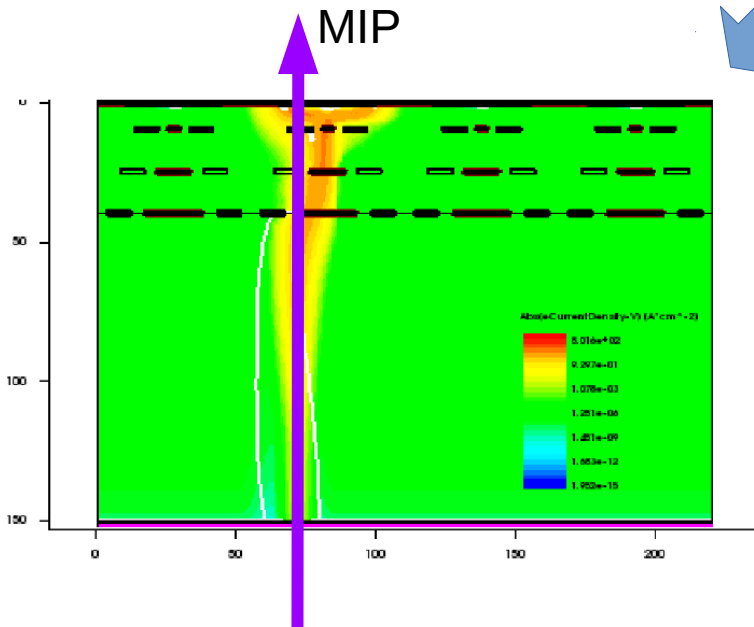
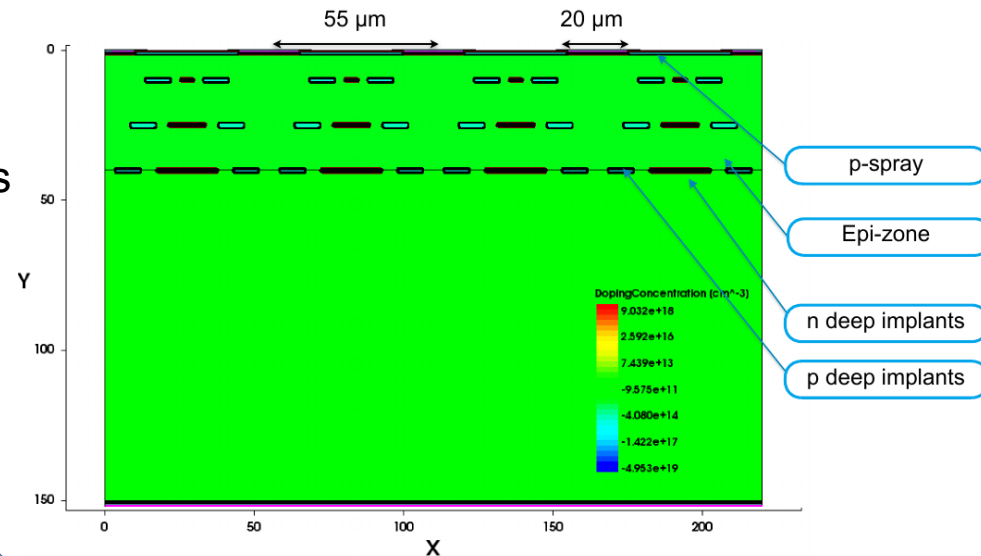
# Status: Where we are now

- Extensive device simulations



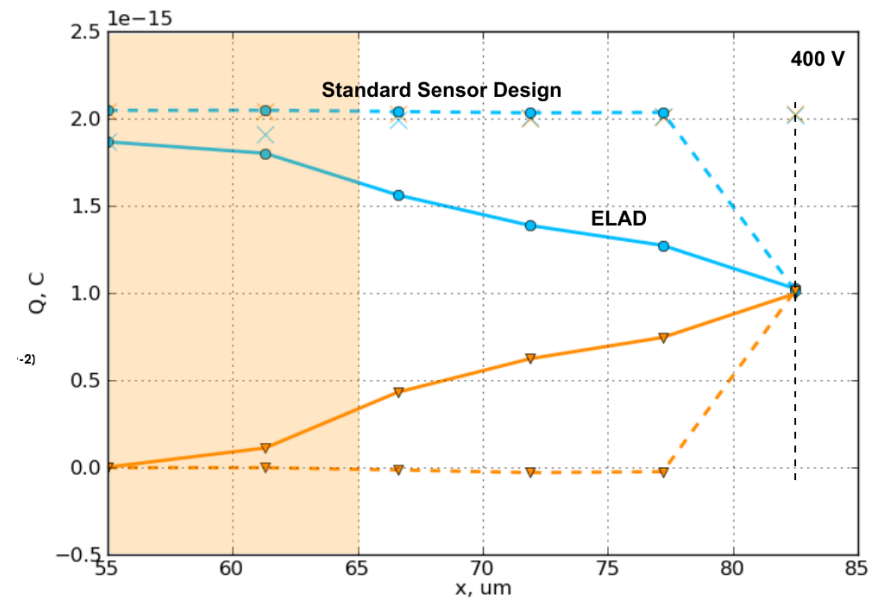
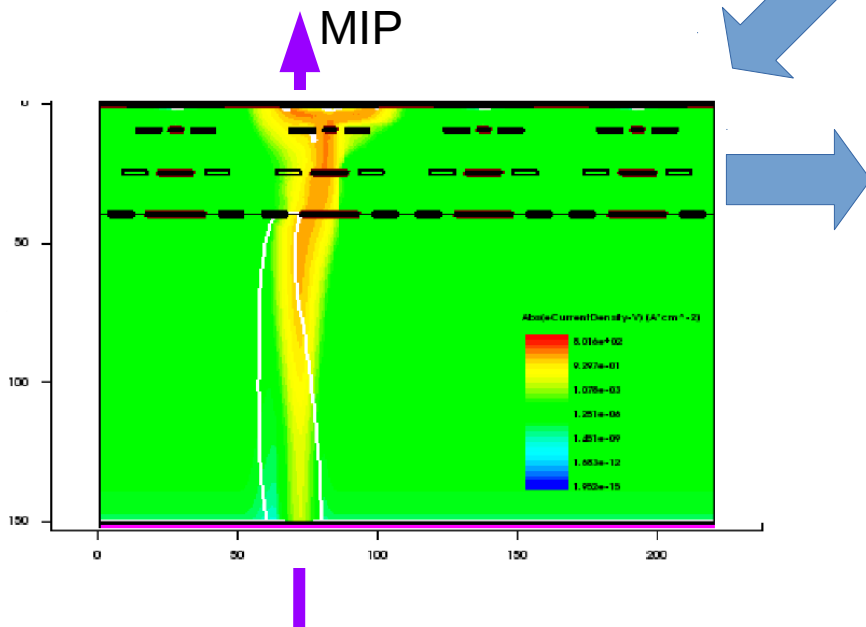
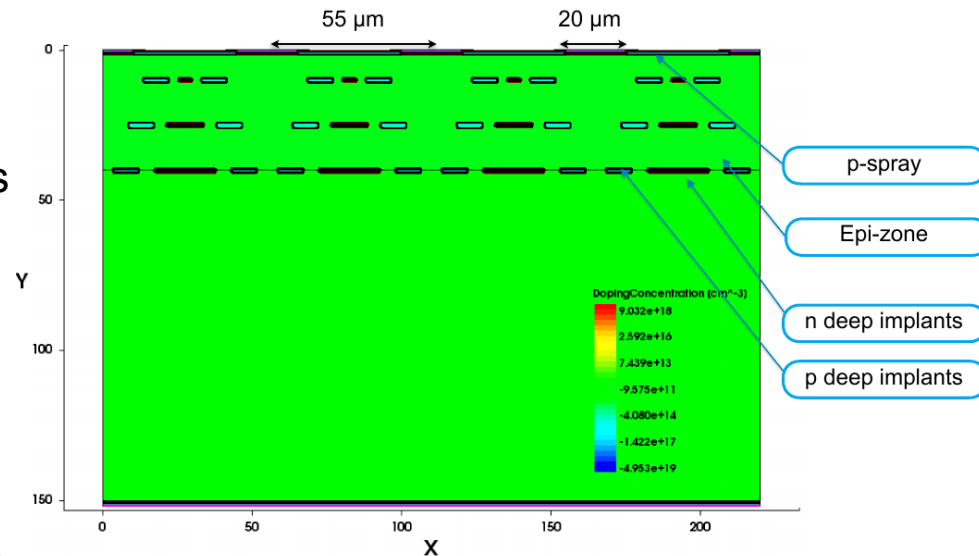
# Status: Where we are now

- **Extensive device simulations**
  - Realistic shapes and sizes of implants
  - Implant concentration
  - Distances b/w layers
  - Distance to first layer



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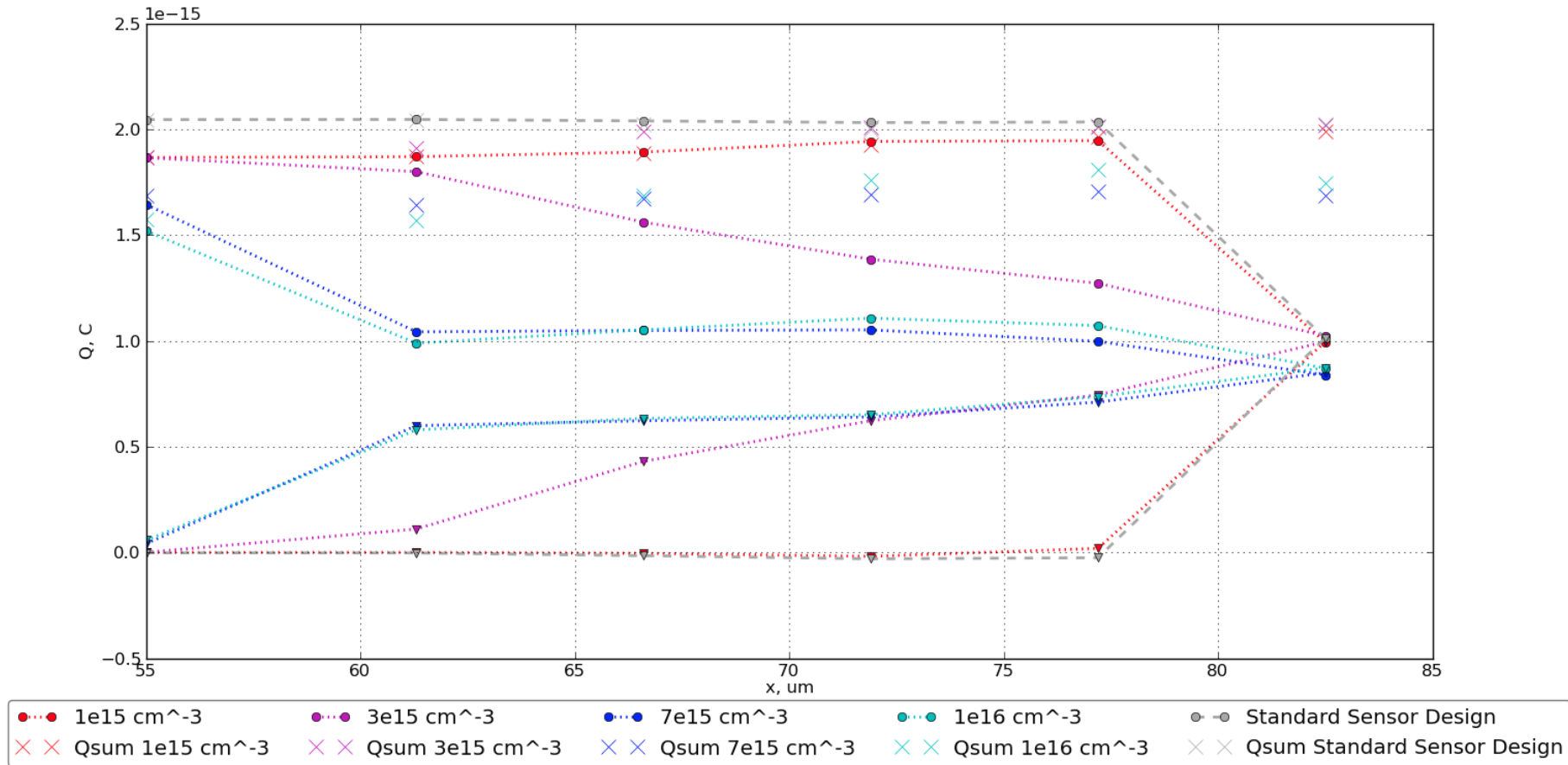
- **Extensive device simulations**
  - Realistic shapes and sizes of implants
  - Implant concentration
  - Distances b/w layers
  - Distance to first layer
  - In simulation, **THE ELAD WORKS**



# Status: Where we are now

## Example of optimisation

- Tuning the implant concentration

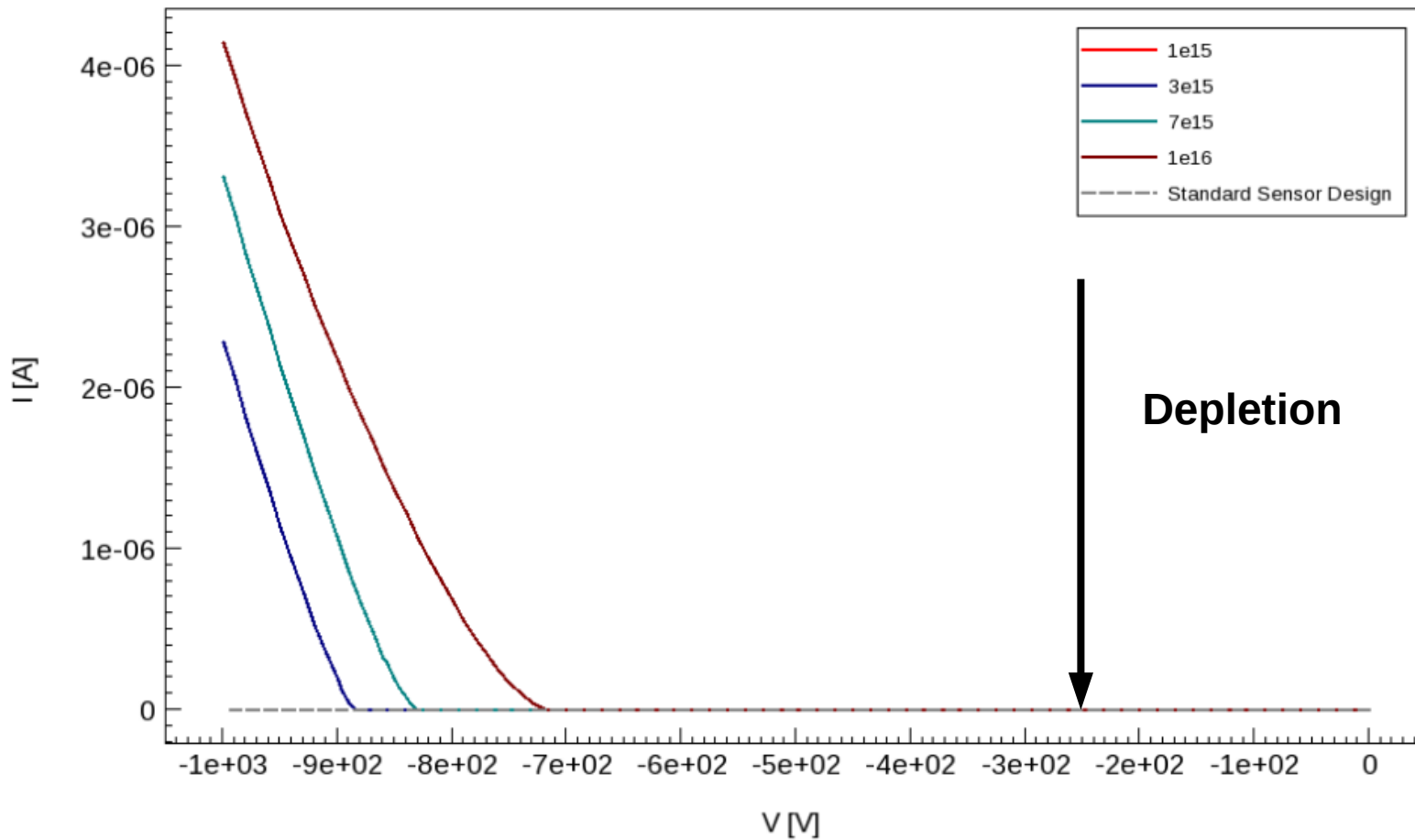


# Status: Where we are now

## Example of optimisation

- Tuning the implant concentration

Total current vs Voltage

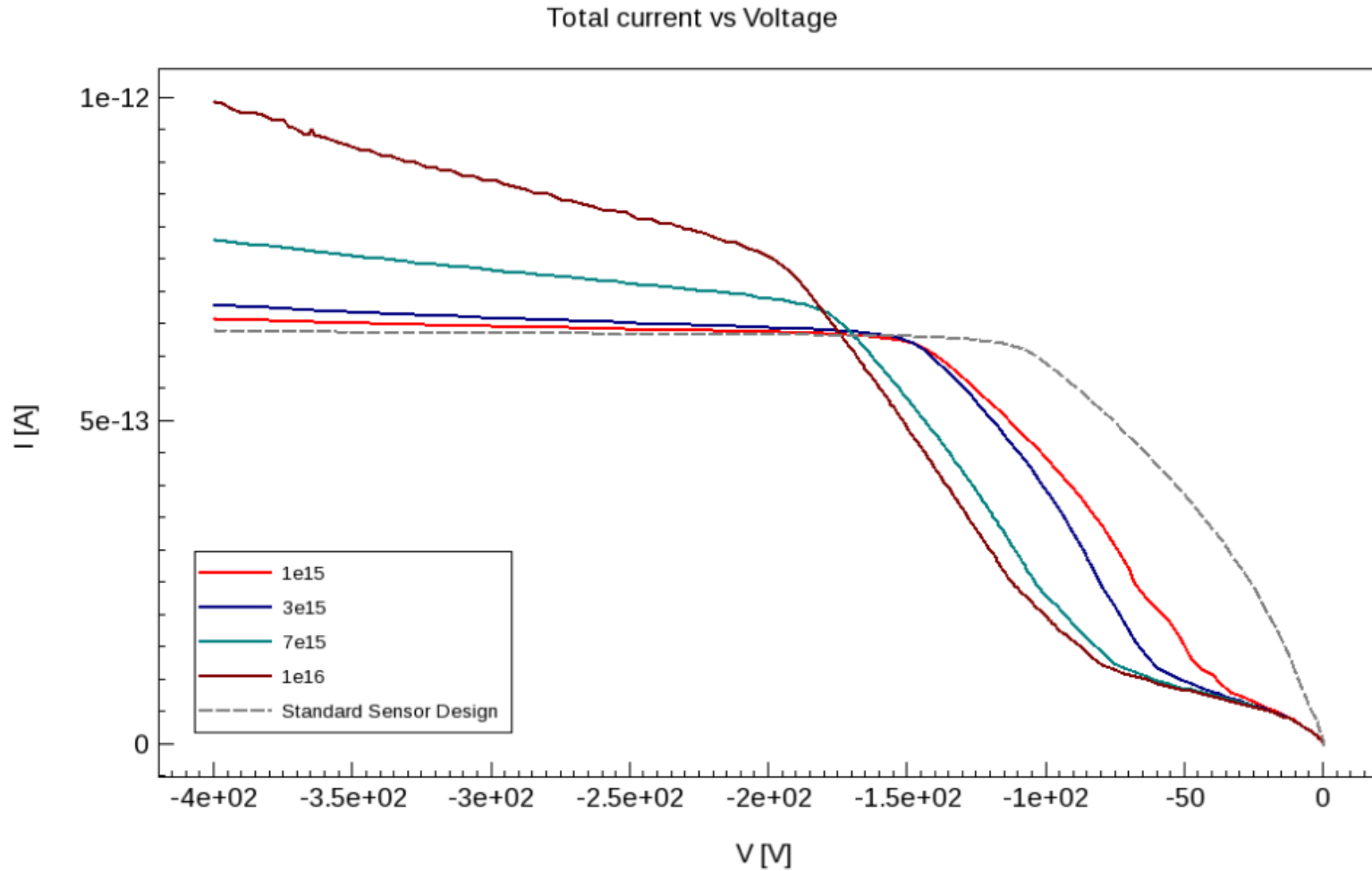




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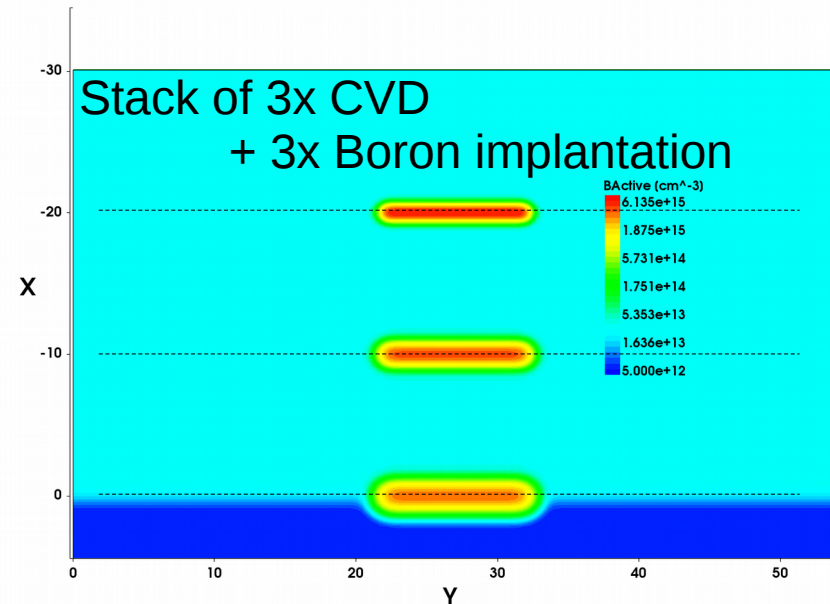
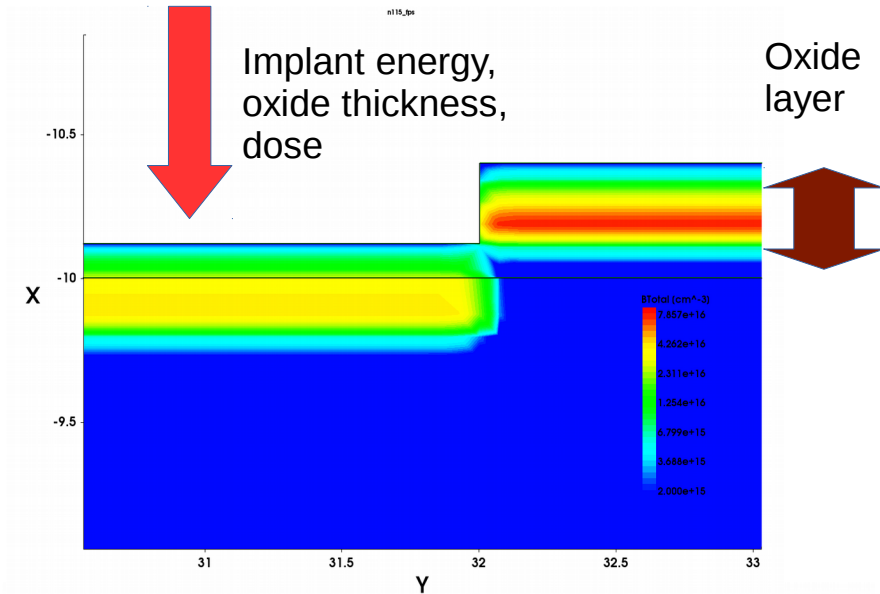
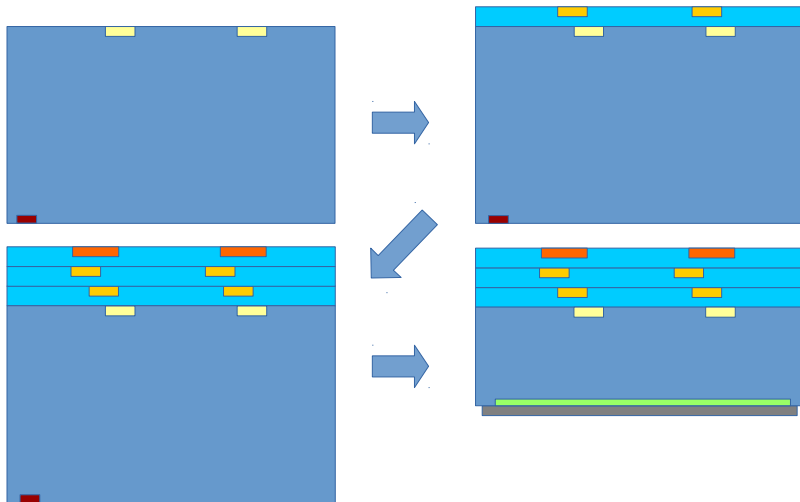
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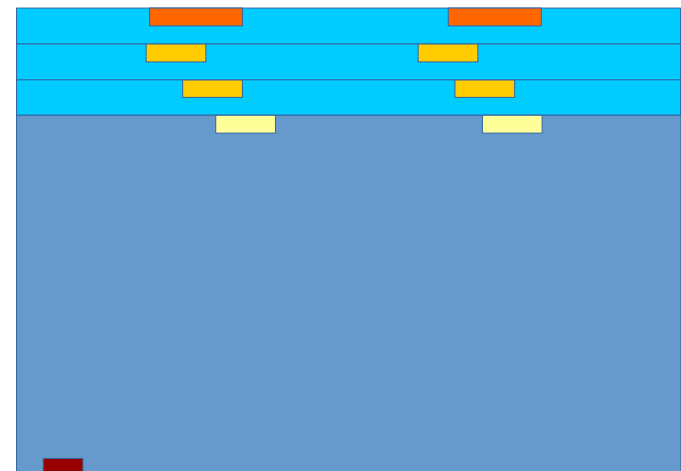
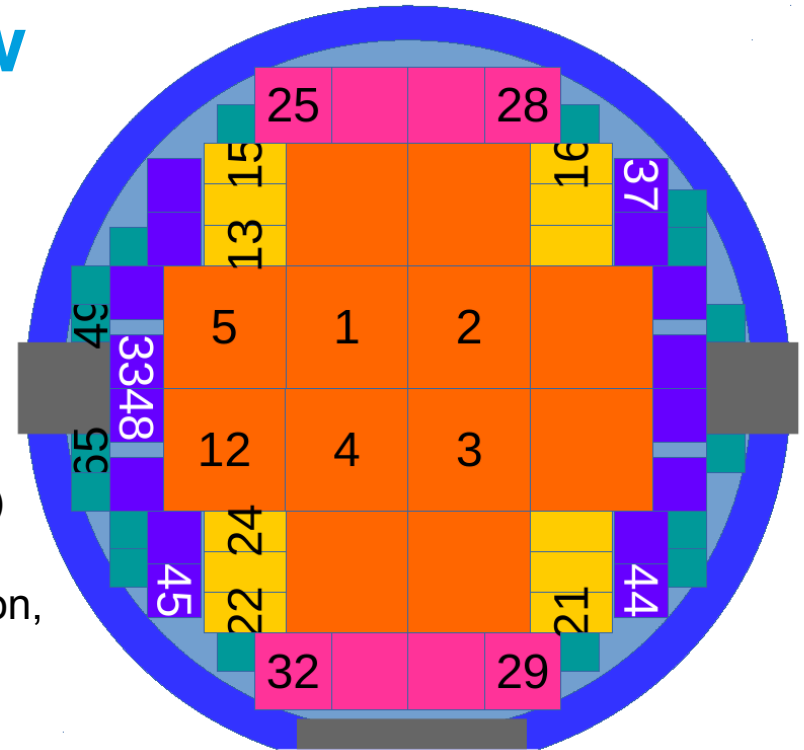
# Status: Where we are now

- Extensive device simulations
- Extensive process simulations
  - Implantation of Boron and Phosphorus
  - Varied the oxide/energy
  - Epitaxial growth (temperature budget)
  - Communicated to 'fab'



# Status: Where we are now

- Extensive device simulations
- Extensive process simulations
- **End of November**
  - Meeting with project partners (ISE, CiS, DESY) at ISE
  - Discussion of technical feasibility, preproduction, project timeline + tour of laboratory
- **Expert review mid January**
  - very valuable input to make production a success
- **At the moment, in parallel:**
  - 1) creation of wafer layout files for production (DESY + CiS)
  - 2) initial tests at ISE for process development (waiting for results)



# Conclusion

- **Technologically challenging project** (no one tried this before in HEP)
- Try to reach **theoretical optimum** of position resolution
- **Interesting technology** for future HEP detectors
- **Opens new possibilities** in sensor design
- Prototypes hopefully in Q2/Q3 2018

